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### Understanding [Embedded - CPLDs \(Complex Programmable Logic Devices\)](#)

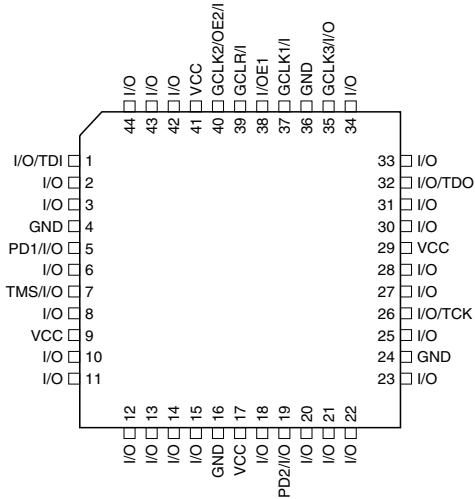
Embedded - CPLDs, or Complex Programmable Logic Devices, are highly versatile digital logic devices used in electronic systems. These programmable components are designed to perform complex logical operations and can be customized for specific applications. Unlike fixed-function ICs, CPLDs offer the flexibility to reprogram their configuration, making them an ideal choice for various embedded systems. They consist of a set of logic gates and programmable interconnects, allowing designers to implement complex logic circuits without needing custom hardware.

### Applications of Embedded - CPLDs

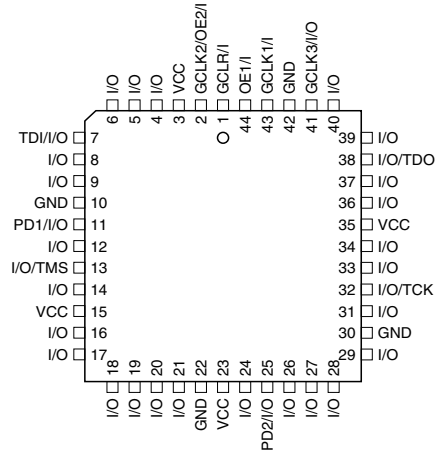
#### Details

Product Status	Obsolete
Programmable Type	In System Programmable (min 10K program/erase cycles)
Delay Time tpd(1) Max	20 ns
Voltage Supply - Internal	3V ~ 3.6V
Number of Logic Elements/Blocks	-
Number of Macrocells	64
Number of Gates	-
Number of I/O	64
Operating Temperature	-40°C ~ 85°C (TA)
Mounting Type	Surface Mount
Package / Case	84-LCC (J-Lead)
Supplier Device Package	84-PLCC (29.31x29.31)
Purchase URL	<a href="https://www.e-xfl.com/product-detail/microchip-technology/atf1504asvl-20ji84">https://www.e-xfl.com/product-detail/microchip-technology/atf1504asvl-20ji84</a>

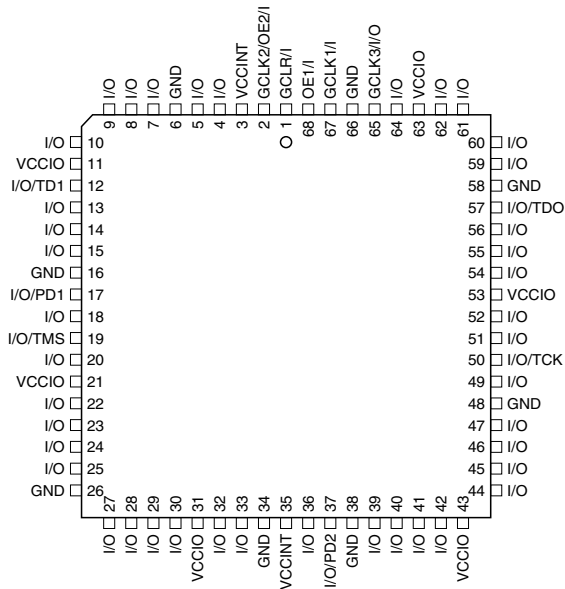
**44-lead TQFP  
Top View**



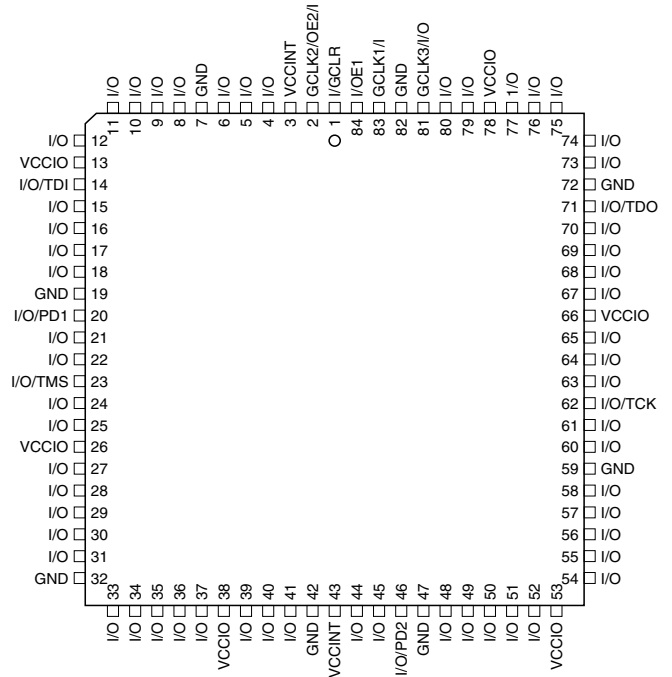
**44-lead PLCC  
Top View**



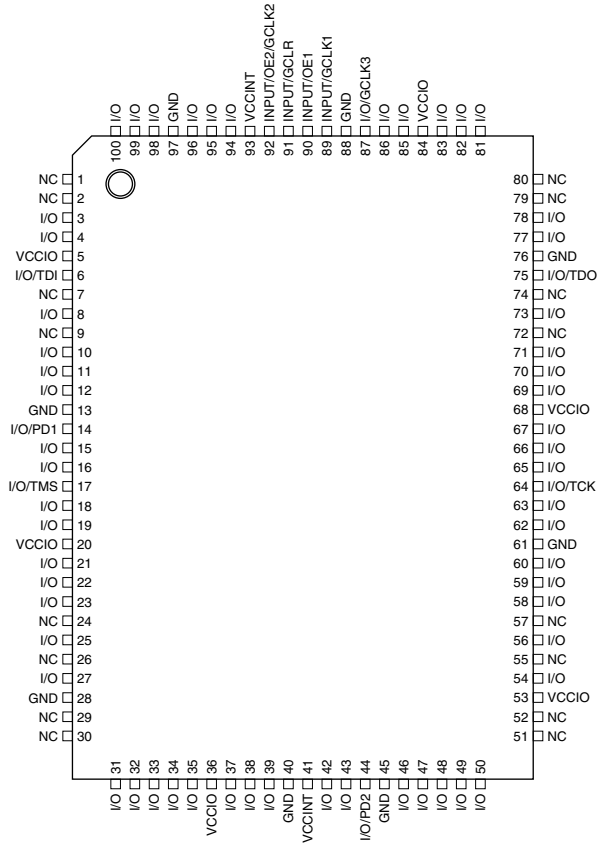
**68-lead PLCC  
Top View**



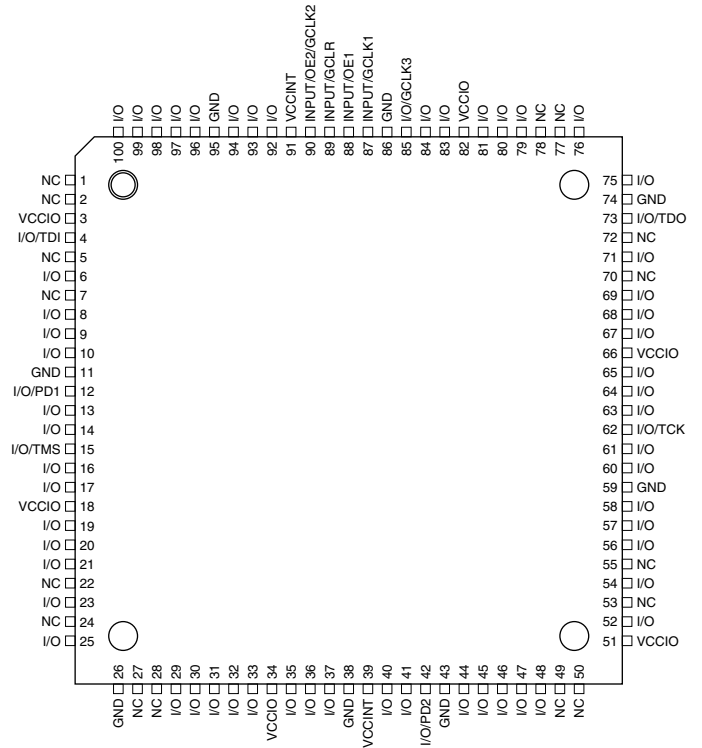
**84-lead PLCC  
Top View**



**100-lead PQFP  
Top View**



**100-lead TQFP  
Top View**



## **OR/XOR/CASCADE Logic**

The ATF1504ASV(L)'s logic structure is designed to efficiently support all types of logic. Within a single macrocell, all the product terms can be routed to the OR gate, creating a 5-input AND/OR sum term. With the addition of the CASIN from neighboring macrocells, this can be expanded to as many as 40 product terms with little additional delay.

The macrocell's XOR gate allows efficient implementation of compare and arithmetic functions. One input to the XOR comes from the OR sum term. The other XOR input can be a product term or a fixed high- or low-level. For combinatorial outputs, the fixed level input allows polarity selection. For registered functions, the fixed levels allow DeMorgan minimization of product terms. The XOR gate is also used to emulate T- and JK-type flip-flops.

## **Flip-flop**

The ATF1504ASV(L)'s flip-flop has very flexible data and control functions. The data input can come from either the XOR gate, from a separate product term or directly from the I/O pin. Selecting the separate product term allows creation of a buried registered feedback within a combinatorial output macrocell. (This feature is automatically implemented by the fitter software). In addition to D, T, JK and SR operation, the flip-flop can also be configured as a flow-through latch. In this mode, data passes through when the clock is high and is latched when the clock is low.

The clock itself can either be one of the Global CLK Signal (GCK[0 : 2]) or an individual product term. The flip-flop changes state on the clock's rising edge. When the GCK signal is used as the clock, one of the macrocell product terms can be selected as a clock enable. When the clock enable function is active and the enable signal (product term) is low, all clock edges are ignored. The flip-flop's asynchronous reset signal (AR) can be either the Global Clear (GCLEAR), a product term, or always off. AR can also be a logic OR of GCLEAR with a product term. The asynchronous preset (AP) can be a product term or always off.

## **Extra Feedback**

The ATF1504ASV(L) macrocell output can be selected as registered or combinatorial. The extra buried feedback signal can be either combinatorial or a registered signal regardless of whether the output is combinatorial or registered. (This enhancement function is automatically implemented by the fitter software.) Feedback of a buried combinatorial output allows the creation of a second latch within a macrocell.

## **I/O Control**

The output enable multiplexer (MOE) controls the output enable signal. Each I/O can be individually configured as an input, output or for bi-directional operation. The output enable for each macrocell can be selected from the true or compliment of the two output enable pins, a subset of the I/O pins, or a subset of the I/O macrocells. This selection is automatically done by the fitter software when the I/O is configured as an input, all macrocell resources are still available, including the buried feedback, expander and cascade logic.

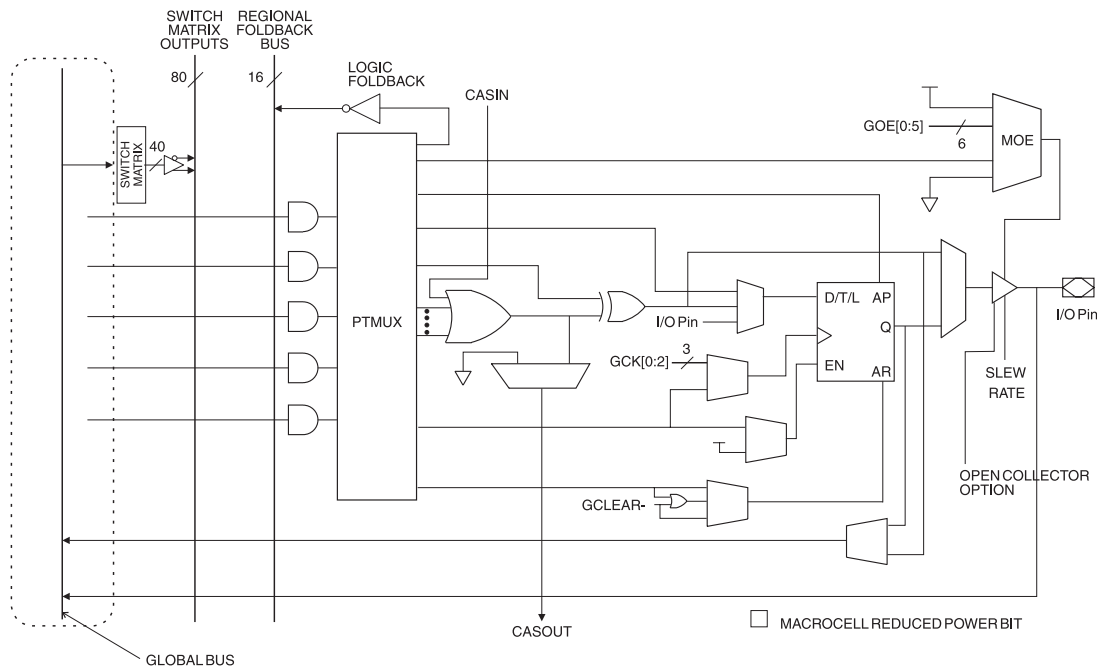
## **Global Bus/Switch Matrix**

The global bus contains all input and I/O pin signals as well as the buried feedback signal from all 64 macrocells. The switch matrix in each logic block receives as its inputs all signals from the global bus. Under software control, up to 40 of these signals can be selected as inputs to the logic block.

## **Foldback Bus**

Each macrocell also generates a foldback product term. This signal goes to the regional bus and is available to four macrocells. The foldback is an inverse polarity of one of the macrocell's product terms. The four foldback terms in each region allow generation of high fan-in sum terms (up to nine product terms) with little additional delay.

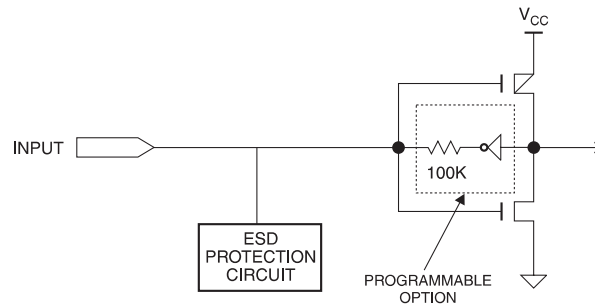
**Figure 1. ATF1504ASV(L) Macrocell**



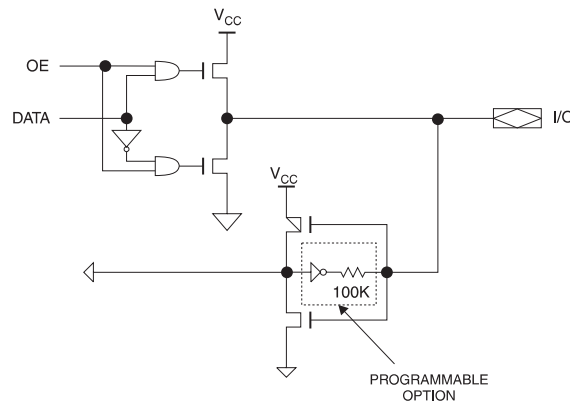
## Programmable Pin-keeper Option for Inputs and I/Os

The ATF1504ASV(L) offers the option of programming all input and I/O pins so that pin keeper circuits can be utilized. When any pin is driven high or low and then subsequently left floating, it will stay at that previous high- or low-level. This circuitry prevents unused input and I/O lines from floating to intermediate voltage levels, which causes unnecessary power consumption and system noise. The keeper circuits eliminate the need for external pull-up resistors and eliminate their DC power consumption.

## Input Diagram



## I/O Diagram



## Speed/Power Management

The ATF1504ASV(L) has several built-in speed and power management features. The ATF1504ASV(L) contains circuitry that automatically puts the device into a low power standby mode when no logic transitions are occurring. This not only reduces power consumption during inactive periods, but also provides proportional power savings for most applications running at system speeds below 5 MHz. This feature may be selected as a device option.

To further reduce power, each ATF1504ASV(L) macrocell has a reduced-power bit feature. This feature allows individual macrocells to be configured for maximum power savings. This feature may be selected as a design option.

All ATF1504ASV(L) also have an optional power-down mode. In this mode, current drops to below 5 mA. When the power-down option is selected, either PD1 or PD2 pins (or both) can be used to power down the part. The power-down option is selected in the design source file. When enabled, the device goes into power down when either PD1 or PD2 is high. In the power-down mode, all internal logic signals are latched and held, as are any enabled outputs.

All pin transitions are ignored until the PD pin is brought low. When the power-down feature is enabled, the PD1 or PD2 pin cannot be used as a logic input or output. However, the pin's macrocell may still be used to generate buried foldback and cascade logic signals.



## Programming

ATF1504ASV(L) devices are in-system programmable (ISP) devices utilizing the 4-pin JTAG protocol. This capability eliminates package handling normally required for programming and facilitates rapid design iterations and field changes.

Atmel provides ISP hardware and software to allow programming of the ATF1504ASV(L) via the PC. ISP is performed by using either a download cable, a comparable board tester or a simple microprocessor interface.

To facilitate ISP programming by the Automated Test Equipment (ATE) vendors. Serial Vector Format (SVF) files can be created by Atmel provided software utilities.

ATF1504ASV(L) devices can also be programmed using standard third-party programmers. With third-party programmer the JTAG ISP port can be disabled thereby allowing four additional I/O pins to be used for logic.

Contact your local Atmel representatives or Atmel PLD applications for details.

## ISP Programming Protection

The ATF1504ASV(L) has a special feature that locks the device and prevents the inputs and I/O from driving if the programming process is interrupted for any reason. The inputs and I/O default to high-Z state during such a condition. In addition the pin keeper option preserves the former state during device programming, if this circuit were previously programmed on the device. This prevents disturbing the operation of other circuits in the system while the ATF1504ASV(L) is being programmed via ISP.

All ATF1504ASV(L) devices are initially shipped in the erased state thereby making them ready to use for ISP.

Note: For more information refer to the "Designing for In-System Programmability with Atmel CPLDs" application note.

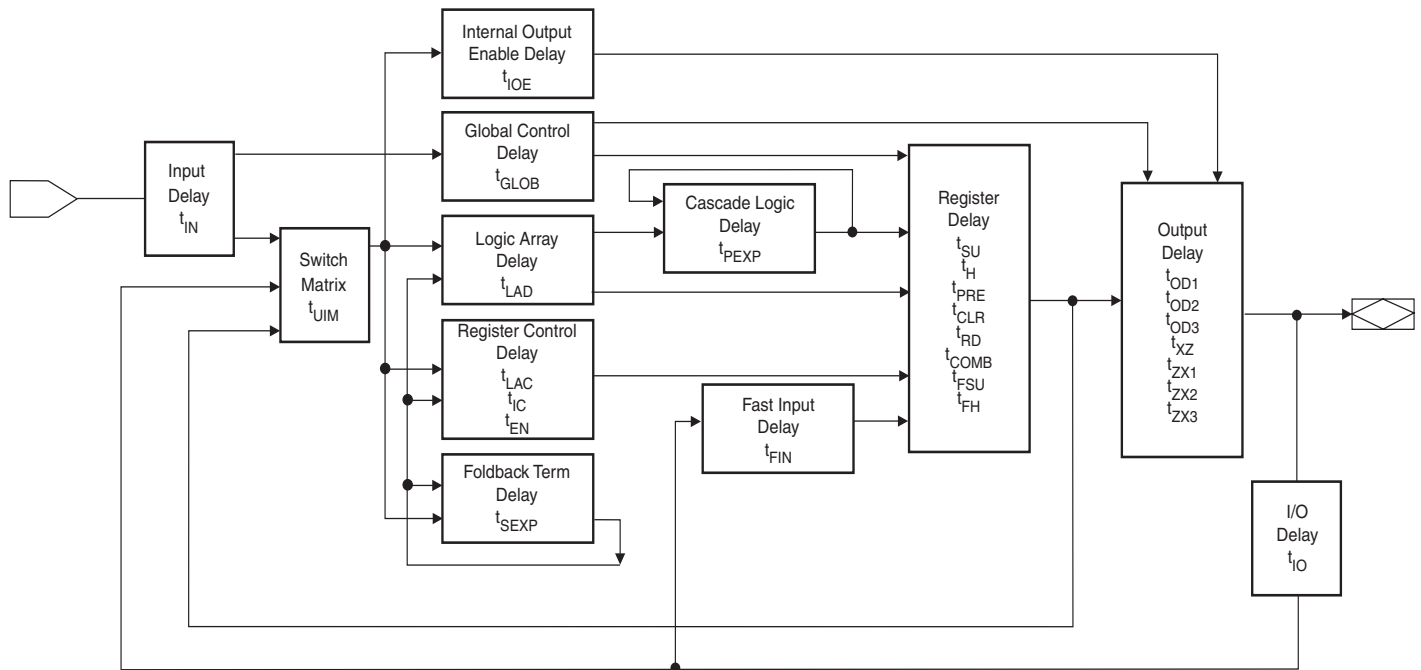
## Absolute Maximum Ratings\*

Temperature Under Bias .....	-40°C to +85°C
Storage Temperature .....	-65°C to +150°C
Voltage on Any Pin with Respect to Ground .....	-2.0V to +7.0V <sup>(1)</sup>
Voltage on Input Pins with Respect to Ground During Programming .....	-2.0V to +14.0V <sup>(1)</sup>
Programming Voltage with Respect to Ground .....	-2.0V to +14.0V <sup>(1)</sup>

**\*NOTICE:** Stresses beyond those listed under “Absolute Maximum Ratings” may cause permanent damage to the device. This is a stress rating only and functional operation of the device at these or any other conditions beyond those indicated in the operational sections of this specification is not implied. Exposure to absolute maximum rating conditions for extended periods may affect device reliability.

**Note:** 1. Minimum voltage is -0.6V DC, which may undershoot to -2.0V for pulses of less than 20 ns. Maximum output pin voltage is  $V_{CC} + 0.75V$  DC, which may overshoot to 7.0V for pulses of less than 20 ns.

## Timing Model





## Power-down Mode

The ATF1504ASV(L) includes an optional pin-controlled power-down feature. When this mode is enabled, the PD pin acts as the power-down pin. When the PD pin is high, the device supply current is reduced to less than 3 mA. During power down, all output data and internal logic states are latched internally and held. Therefore, all registered and combinatorial output data remain valid. Any outputs that were in a High-Z state at the onset will remain at High-Z. During power down, all input signals except the power-down pin are blocked. Input and I/O hold latches remain active to ensure that pins do not float to indeterminate levels, further reducing system power. The power-down mode feature is enabled in the logic design file or as a fitted or translated s/w option. Designs using the power-down pin may not use the PD pin as a logic array input. However, all other PD pin macrocell resources may still be used, including the buried feedback and foldback product term array inputs.

## Power Down AC Characteristics<sup>(1)(2)</sup>

Symbol	Parameter	-15		-20		Units
		Min	Max	Min	Max	
$t_{IVDH}$	Valid I, I/O before PD High	15		20		ns
$t_{GVDH}$	Valid OE <sup>(2)</sup> before PD High	15		20		ns
$t_{CVDH}$	Valid Clock <sup>(2)</sup> before PD High	15		20		ns
$t_{DHIX}$	I, I/O Don't Care after PD High		25		30	ns
$t_{DHGX}$	OE <sup>(2)</sup> Don't Care after PD High		25		30	ns
$t_{DHCX}$	Clock <sup>(2)</sup> Don't Care after PD High		25		30	ns
$t_{DLIV}$	PD Low to Valid I, I/O		1		1	μs
$t_{DLGV}$	PD Low to Valid OE (Pin or Term)		1		1	μs
$t_{DLCV}$	PD Low to Valid Clock (Pin or Term)		1		1	μs
$t_{DLOV}$	PD Low to Valid Output		1		1	μs

- Notes:
1. For slow slew outputs, add  $t_{SSO}$ .
  2. Pin or product term.
  3. Includes  $t_{RPA}$  for reduced-power bit enabled.

## JTAG-BST/ISP Overview

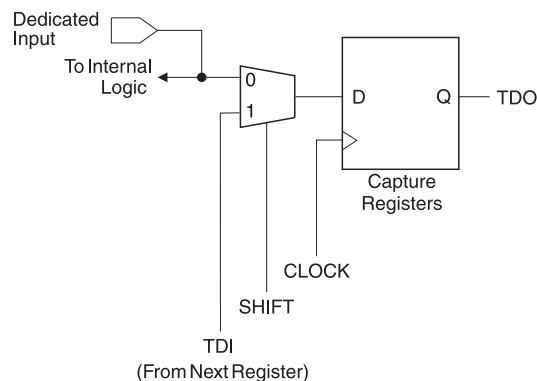
The JTAG boundary-scan testing is controlled by the Test Access Port (TAP) controller in the ATF1504ASV(L). The boundary-scan technique involves the inclusion of a shift-register stage (contained in a boundary-scan cell) adjacent to each component so that signals at component boundaries can be controlled and observed using scan testing principles. Each input pin and I/O pin has its own boundary-scan cell (BSC) in order to support boundary-scan testing. The ATF1504ASV(L) does not currently include a Test Reset (TRST) input pin because the TAP controller is automatically reset at power-up. The five JTAG modes supported include: SAMPLE/PRELOAD, EXTEST, BYPASS, IDCODE and HIGHZ. The ATF1504ASV(L)'s ISP can be fully described using JTAG's BSDL as described in IEEE Standard 1149.1b. This allows ATF1504ASV(L) programming to be described and implemented using any one of the third-party development tools supporting this standard.

The ATF1504ASV(L) has the option of using four JTAG-standard I/O pins for boundary-scan testing (BST) and in-system programming (ISP) purposes. The ATF1504ASV(L) is programmable through the four JTAG pins using the IEEE standard JTAG programming protocol established by IEEE Standard 1149.1 using 5V TTL-level programming signals from the ISP interface for in-system programming. The JTAG feature is a programmable option. If JTAG (BST or ISP) is not needed, then the four JTAG control pins are available as I/O pins.

## JTAG Boundary-scan Cell (BSC) Testing

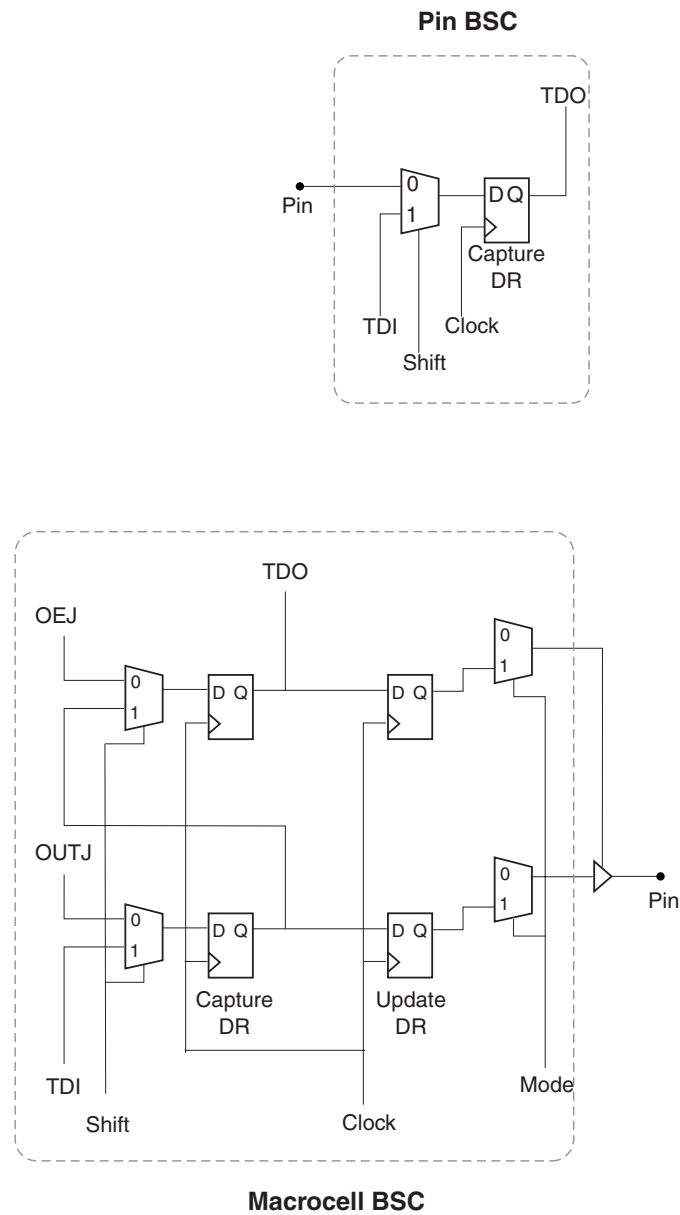
The ATF1504ASV(L) contains up to 68 I/O pins and four input pins, depending on the device type and package type selected. Each input pin and I/O pin has its own boundary-scan cell (BSC) in order to support boundary-scan testing as described in detail by IEEE Standard 1149.1. A typical BSC consists of three capture registers or scan registers and up to two update registers. There are two types of BSCs, one for input or I/O pin, and one for the macrocells. The BSCs in the device are chained together through the capture registers. Input to the capture register chain is fed in from the TDI pin while the output is directed to the TDO pin. Capture registers are used to capture active device data signals, to shift data in and out of the device and to load data into the update registers. Control signals are generated internally by the JTAG TAP controller. The BSC configuration for the input and I/O pins and macrocells are shown below.

## BSC Configuration for Input and I/O Pins (Except JTAG TAP Pins)



**Note:** The ATF1504ASV(L) has pull-up option on TMS and TDI pins. This feature is selected as a design option.

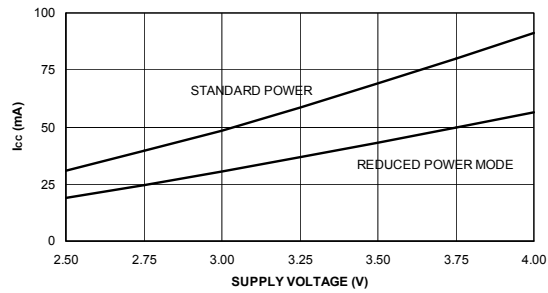
## BSC Configuration for Macrocell



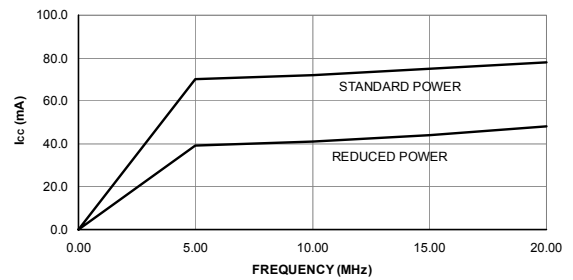
## ATF1504ASV I/O Pinouts

MC	PLC	44-lead PLCC	44-lead TQFP	68-lead PLCC	84-lead PLCC	100- lead PQFP	100- lead TQFP	MC	PLC	44-lead PLCC	44-lead TQFP	68-lead PLCC	84-lead PLCC	100- lead PQFP	100- lead TQFP
1	A	12	6	18	22	16	14	33	C	24	18	36	44	42	40
2	A	-	-	-	21	15	13	34	C	-	-	-	45	43	41
3	A/ PD1	11	5	17	20	14	12	35	C/ PD2	25	19	37	46	44	42
4	A	9	3	15	18	12	10	36	C	26	20	39	48	46	44
5	A	8	2	14	17	11	9	37	C	27	21	40	49	47	45
6	A	-	-	13	16	10	8	38	C	-	-	41	50	48	46
7	A	-	-	-	15	8	6	39	C	-	-	-	51	49	47
8/ TDI	A	7	1	12	14	6	4	40	C	28	22	42	52	50	48
9	A	-	-	10	12	4	100	41	C	29	23	44	54	54	52
10	A	-	-	-	11	3	99	42	C	-	-	-	55	56	54
11	A	6	44	9	10	100	98	43	C	-	-	45	56	58	56
12	A	-	-	8	9	99	97	44	C	-	-	46	57	59	57
13	A	-	-	7	8	98	96	45	C	-	-	47	58	60	58
14	A	5	43	5	6	96	94	46	C	31	25	49	60	62	60
15	A	-	-	-	5	95	93	47	C	-	-	-	61	63	61
16	A	4	42	4	4	94	92	48/ TCK	C	32	26	50	62	64	62
17	B	21	15	33	41	39	37	49	D	33	27	51	63	65	63
18	B	-	-	-	40	38	36	50	D	-	-	-	64	66	64
19	B	20	14	32	39	37	35	51	D	34	28	52	65	67	65
20	B	19	13	30	37	35	33	52	D	36	30	54	67	69	67
21	B	18	12	29	36	34	32	53	D	37	31	55	68	70	68
22	B	-	-	28	35	33	31	54	D	-	-	56	69	71	69
23	B	-	-	-	34	32	30	55	D	-	-	-	70	73	71
24	B	17	11	27	33	31	29	56/ TDO	D	38	32	57	71	75	73
25	B	16	10	25	31	27	25	57	D	39	33	59	73	77	75
26	B	-	-	-	30	25	23	58	D	-	-	-	74	78	76
27	B	-	-	24	29	23	21	59	D	-	-	60	75	81	79
28	B	-	-	23	28	22	20	60	D	-	-	61	76	82	80
29	B	-	-	22	27	21	19	61	D	-	-	62	77	83	81
30	B	14	8	20	25	19	17	62	D	40	34	64	79	85	83
31	B	-	-	-	24	18	16	63	D	-	-	-	80	86	84
32/ TMS	B	13	7	19	23	17	15	64	D/ GCLK3	41	35	65	81	87	85

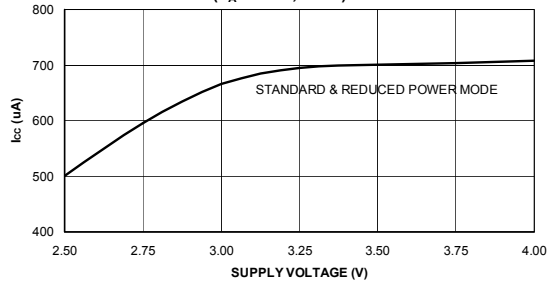
**SUPPLY CURRENT VS. SUPPLY VOLTAGE**  
( $T_A = 25^\circ\text{C}$ ,  $F = 0$ )



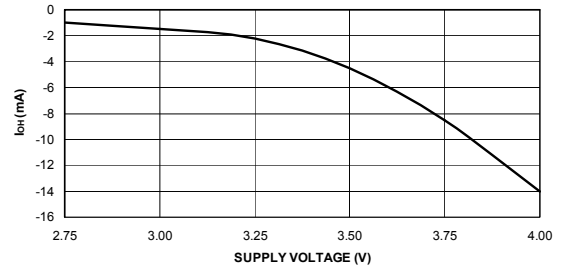
**SUPPLY CURRENT VS. FREQUENCY**  
LOW-POWER ("L") VERSION  
( $T_A = 25^\circ\text{C}$ )



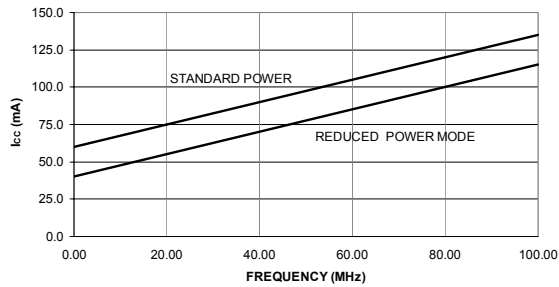
**SUPPLY CURRENT VS. SUPPLY VOLTAGE**  
PIN-CONTROLLED POWER-DOWN MODE  
( $T_A = 25^\circ\text{C}$ ,  $F = 0$ )



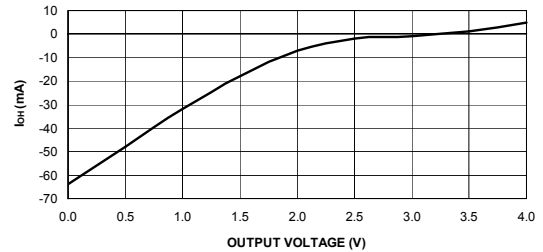
**OUTPUT SOURCE CURRENT**  
VS. SUPPLY VOLTAGE  
( $V_{OH} = 2.4\text{V}$ ,  $T_A = 25^\circ\text{C}$ )



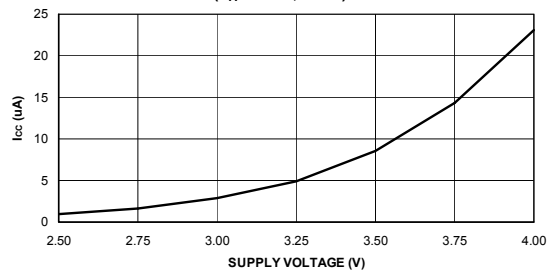
**SUPPLY CURRENT VS. FREQUENCY**  
STANDARD POWER ( $T_A = 25^\circ\text{C}$ )



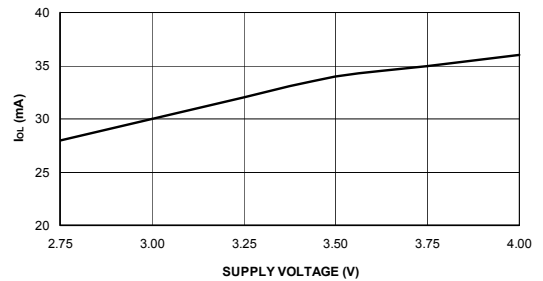
**OUTPUT SOURCE CURRENT**  
VS. OUTPUT VOLTAGE  
( $V_{CC} = 3.3\text{V}$ ,  $T_A = 25^\circ\text{C}$ )



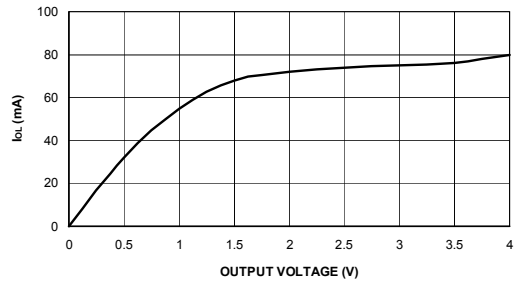
**SUPPLY CURRENT VS. SUPPLY VOLTAGE**  
LOW-POWER ("L") VERSION  
( $T_A = 25^\circ\text{C}$ ,  $F = 0$ )



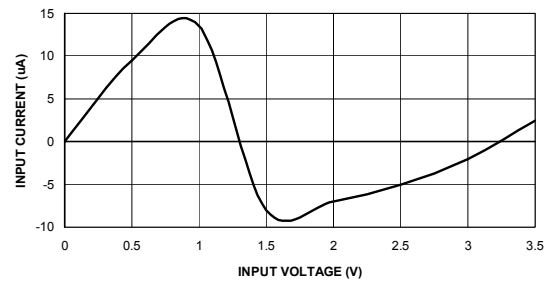
**OUTPUT SINK CURRENT VS. SUPPLY VOLTAGE**  
( $V_{OL} = 0.5\text{V}$ ,  $T_A = 25^\circ\text{C}$ )



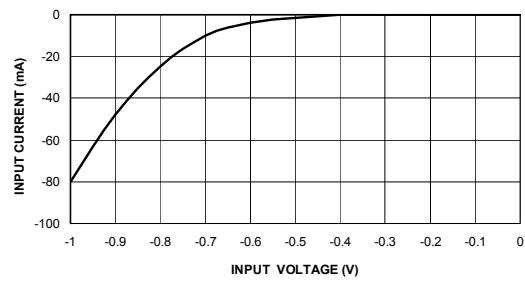
OUTPUT SINK CURRENT VS. OUTPUT VOLTAGE  
( $V_{CC} = 3.3V$ ,  $T_A = 25^\circ C$ )



INPUT CURRENT VS. INPUT VOLTAGE  
( $V_{CC} = 3.3V$ ,  $T_A = 25^\circ C$ )



INPUT CLAMP CURRENT VS. INPUT VOLTAGE  
( $V_{CC} = 3.3V$ ,  $T_A = 25^\circ C$ )



## Ordering Information

### ATF1504ASV(L) Standard Package Options

$t_{PD}$ (ns)	$t_{CO1}$ (ns)	$f_{MAX}$ (MHz)	Ordering Code	Package	Operation Range
15	8	100	ATF1504ASV-15 AC44	44A	Commercial (0°C to 70°C)
			ATF1504ASV-15 JC44	44J	
			ATF1504ASV-15 JC68 <sup>(2)</sup>	68J	
			ATF1504ASV-15 JC84 <sup>(3)</sup>	84J	
			ATF1504ASV-15 QC100 <sup>(2)</sup>	100Q1	
			ATF1500ASV-15 AC100	100A	
15	8	100	ATF1504ASV-15 AI44	44A	Industrial (-40°C to +85°C)
			ATF1504ASV-15 JI44	44J	
			ATF1504ASV-15 JI68	68J	
			ATF1504ASV-15 JI84	84J	
			ATF1504ASV-15 QI100	100Q1	
			ATF1504ASV-15 AI100	100A	
20	12	83.3	ATF1504ASVL-20 AC44	44A	Commercial (0°C to 70°C)
			ATF1504ASVL-20 JC44	44J	
			ATF1504ASVL-20 JC68 <sup>(2)</sup>	68J	
			ATF1504ASVL-20 JC84 <sup>(3)</sup>	84J	
			ATF1504ASVL-20 QC100 <sup>(2)</sup>	100Q1	
			ATF1504ASVL-20 AC100	100A	
20	12	83.3	ATF1504ASVL-20 AI44	44A	Industrial (-40°C to +85°C)
			ATF1504ASVL-20 JI44	44J	
			ATF1504ASVL-20 JI68	68J	
			ATF1504ASVL-20 JI84	84J	
			ATF1504ASVL-20 QI100	100Q1	
			ATF1504ASVL-20 AI100	100A	

- Note:
1. The last time buy is Sept. 30, 2005 for shaded parts.
  2. The recommended migration for QC100 or JC68 packages is the AU100 or the smaller JU44 packages.
  3. The recommended migration for the JC84 package is the ATF1508ASV-15JU84

### Using “C” Product for Industrial

There is very little risk in using “C” devices for industrial applications because the  $V_{CC}$  conditions for 3.3V products are the same for commercial and industrial (there is only 15°C difference at the high end of the temperature range). To use commercial product for industrial temperature ranges, de-rate  $I_{CC}$  by 15%.

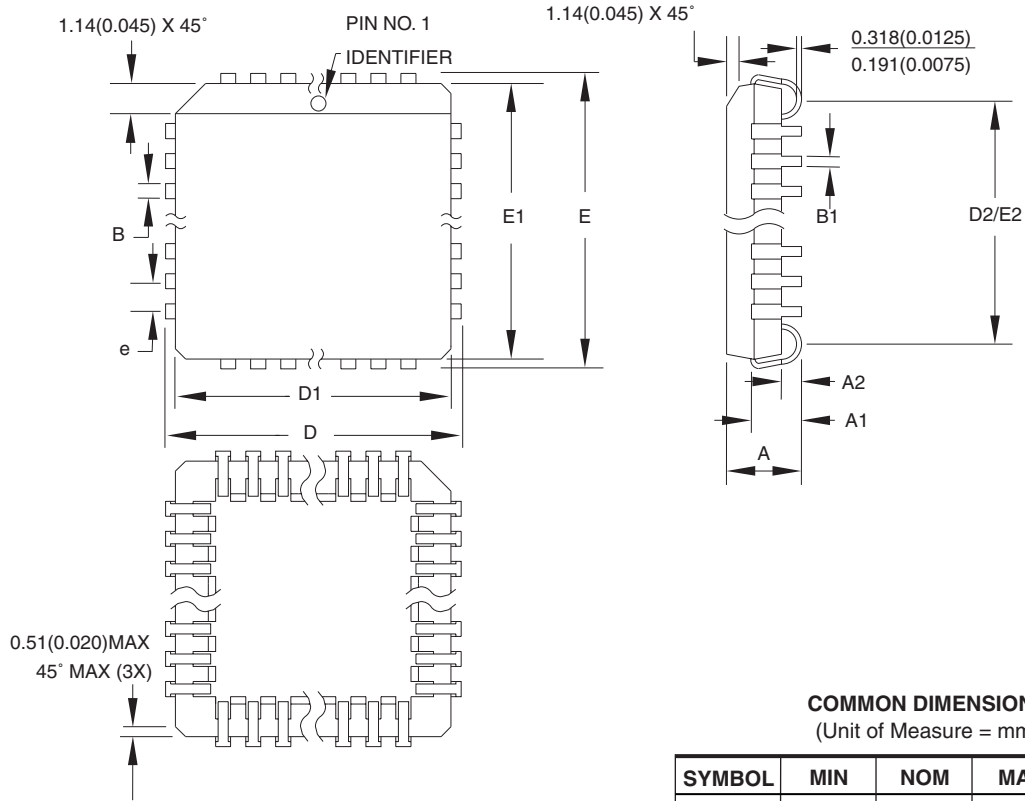
## ATF1504ASV(L) Green Package Options (Pb/Halide-free/RoHS Compliant)

$t_{PD}$ (ns)	$t_{CO1}$ (ns)	$f_{MAX}$ (MHz)	Ordering Code	Package	Operation Range
15	8	100	ATF1504ASV-15 AU44	44A	Industrial (-40°C to +85°C)
			ATF1504ASV-15 JU44	44J	
			ATF1504ASV-15 AU100	100A	
20	12	83.3	ATF1504ASVL-20 AU44	44A	Industrial (-40°C to +85°C)
			ATF1504ASVL-20 JU44	44J	
			ATF1504ASVL-20 AU100	100A	

Package Type	
<b>44A</b>	44-lead, Thin Plastic Gull Wing Quad Flatpack (TQFP)
<b>44J</b>	44-lead, Plastic J-leaded Chip Carrier (PLCC)
<b>68J</b>	68-lead, Plastic J-leaded Chip Carrier (PLCC)
<b>84J</b>	84-lead, Plastic J-leaded Chip Carrier (PLCC)
<b>100Q1</b>	100-lead, 14 x 20 mm Body, Plastic Quad Flat Package (PQFP)
<b>100A</b>	100-lead, 14 x 14 mm Body, Thin Profile Plastic Quad Flat Package (TQFP)



## 44J – PLCC



- Notes:
1. This package conforms to JEDEC reference MS-018, Variation AC.
  2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is .010" (0.254 mm) per side. Dimension D1 and E1 include mold mismatch and are measured at the extreme material condition at the upper or lower parting line.
  3. Lead coplanarity is 0.004" (0.102 mm) maximum.

**COMMON DIMENSIONS**  
(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
A	4.191	—	4.572	
A1	2.286	—	3.048	
A2	0.508	—	—	
D	17.399	—	17.653	
D1	16.510	—	16.662	Note 2
E	17.399	—	17.653	
E1	16.510	—	16.662	Note 2
D2/E2	14.986	—	16.002	
B	0.660	—	0.813	
B1	0.330	—	0.533	
e	1.270 TYP			

10/04/01



2325 Orchard Parkway  
San Jose, CA 95131

**TITLE**

**44J**, 44-lead, Plastic J-leaded Chip Carrier (PLCC)

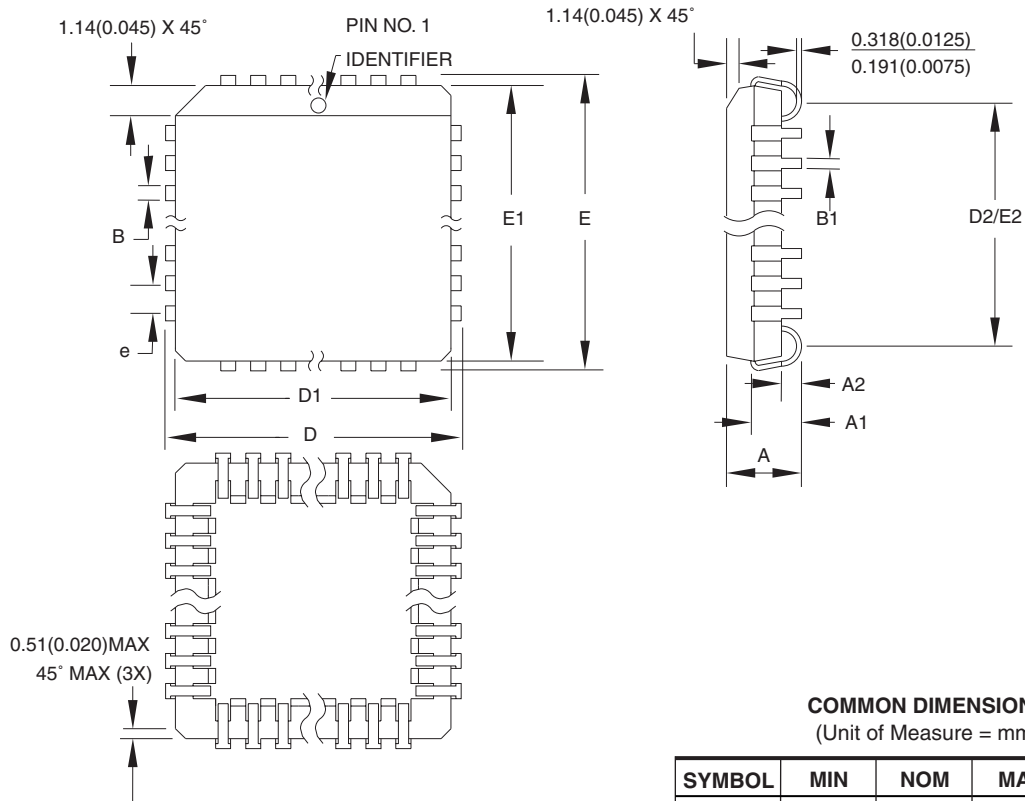
**DRAWING NO.**

44J

**REV.**

B

## 68J – PLCC



**COMMON DIMENSIONS**  
(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
A	4.191	—	4.572	
A1	2.286	—	3.048	
A2	0.508	—	—	
D	25.019	—	25.273	
D1	24.130	—	24.333	Note 2
E	25.019	—	25.273	
E1	24.130	—	24.333	Note 2
D2/E2	22.606	—	23.622	
B	0.660	—	0.813	
B1	0.330	—	0.533	
e	1.270 TYP			

- Notes:
1. This package conforms to JEDEC reference MS-018, Variation AE.
  2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is .010" (0.254 mm) per side. Dimension D1 and E1 include mold mismatch and are measured at the extreme material condition at the upper or lower parting line.
  3. Lead coplanarity is 0.004" (0.102 mm) maximum.

10/04/01



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### TITLE

**68J, 68-lead, Plastic J-leaded Chip Carrier (PLCC)**

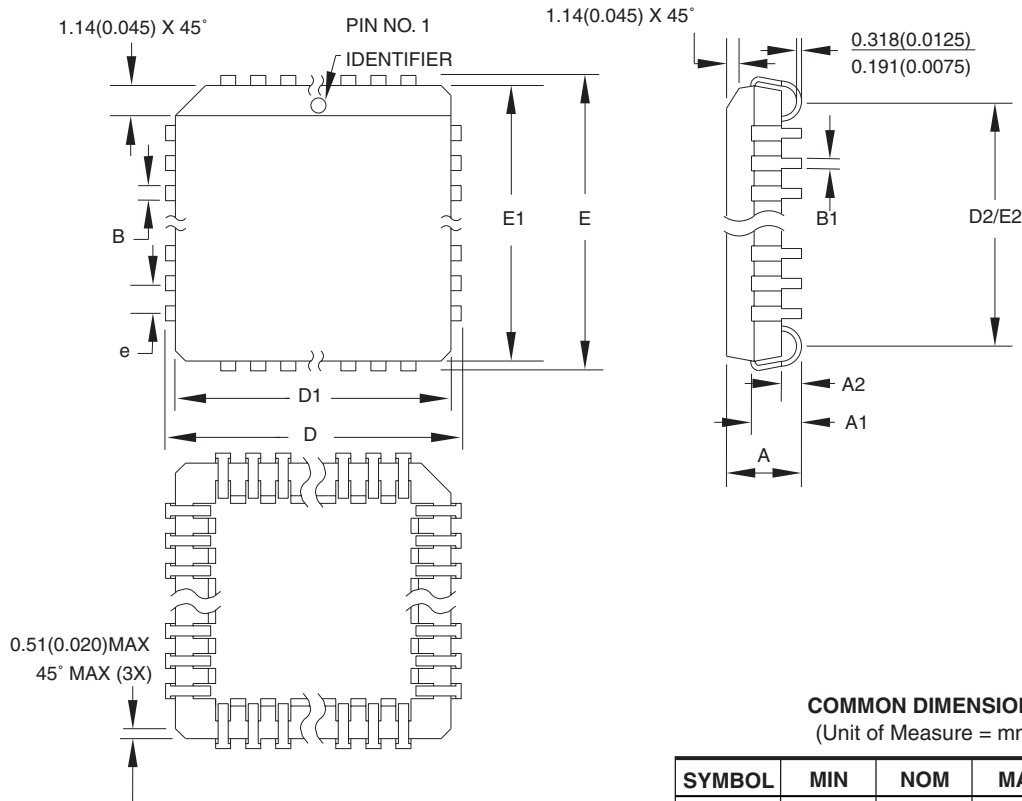
### DRAWING NO.

68J

### REV.

B

## 84J – PLCC



**COMMON DIMENSIONS**  
(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
A	4.191	—	4.572	
A1	2.286	—	3.048	
A2	0.508	—	—	
D	30.099	—	30.353	
D1	29.210	—	29.413	Note 2
E	30.099	—	30.353	
E1	29.210	—	29.413	Note 2
D2/E2	27.686	—	28.702	
B	0.660	—	0.813	
B1	0.330	—	0.533	
e	1.270 TYP			

- Notes:
1. This package conforms to JEDEC reference MS-018, Variation AF.
  2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is .010" (0.254 mm) per side. Dimension D1 and E1 include mold mismatch and are measured at the extreme material condition at the upper or lower parting line.
  3. Lead coplanarity is 0.004" (0.102 mm) maximum.

10/04/01



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San Jose, CA 95131

### TITLE

**84J**, 84-lead, Plastic J-leaded Chip Carrier (PLCC)

### DRAWING NO.

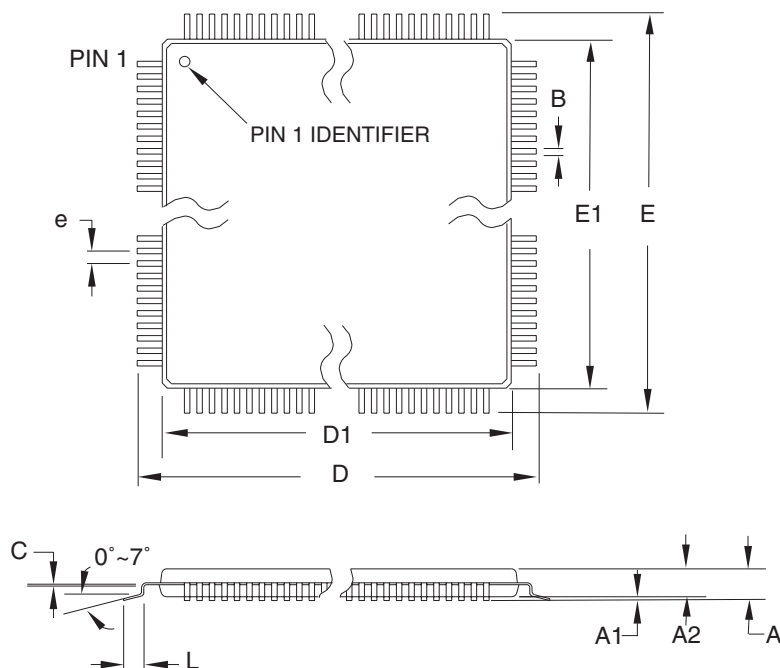
84J

### REV.

B



100A – TQFP



**COMMON DIMENSIONS**  
(Unit of Measure = mm)

SYMBOL	MIN	NOM	MAX	NOTE
A	—	—	1.20	
A1	0.05	—	0.15	
A2	0.95	1.00	1.05	
D	15.75	16.00	16.25	
D1	13.90	14.00	14.10	Note 2
E	15.75	16.00	16.25	
E1	13.90	14.00	14.10	Note 2
B	0.17	—	0.27	
C	0.09	—	0.20	
L	0.45	—	0.75	
e	0.50 TYP			

- Notes:
1. This package conforms to JEDEC reference MS-026, Variation AED.
  2. Dimensions D1 and E1 do not include mold protrusion. Allowable protrusion is 0.25 mm per side. Dimensions D1 and E1 are maximum plastic body size dimensions including mold mismatch.
  3. Lead coplanarity is 0.08 mm maximum.

10/5/2001



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**TITLE**

**100A**, 100-lead, 14 x 14 mm Body Size, 1.0 mm Body Thickness,  
0.5 mm Lead Pitch, Thin Profile Plastic Quad Flat Package (TQFP)

**DRAWING NO.**

100A

**REV.**

C





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